

Q1PACK Module

NXH75M65L4Q1SG, NXH75M65L4Q1PTG

This high-density, integrated power module combines high-performance IGBTs with rugged anti-parallel diodes.

Features

- Extremely Efficient Trench with Fieldstop Technology
- Low Switching Loss Reduces System Power Dissipation
- Module Design Offers High Power Density
- Low Inductive Layout
- Q1PACK Packages with Solder and Pressfit Pins

Typical Applications

- Solar Inverters
- Uninterruptable Power Supplies

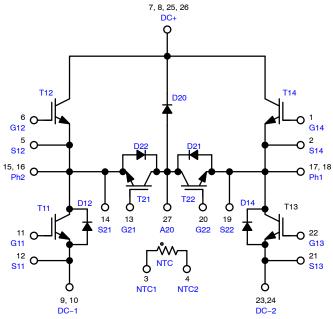


Figure 1. Schematic

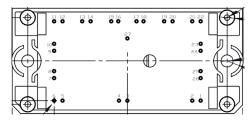
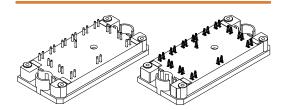


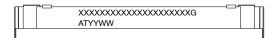
Figure 2. Pin Assignments

75 A, 650 V Module



PIM27, 71x37.4 (SOLDER PIN) CASE 180CA PIM27, 71x37.4 (PRESSFIT PIN) CASE 180CP

MARKING DIAGRAM



XXXXX = Specific Device Code
G = Pb-Free Package
AT = Assembly & Test Site Code

AT = Assembly & Test Site Code YYWW = Year and Work Week Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 9 of this data sheet.

ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
GBT (T11, T12, T13, T14, T21, T22)	•		
Collector-emitter voltage	V_{CES}	650	V
Collector current @ T _h = 80°C (per IGBT)	I _C	59	Α
Pulsed collector current, T _{pulse} limited by T _{jmax}	I _{CM}	176	Α
Power Dissipation Per IGBT $T_j = T_{jmax}, T_h = 80^{\circ}C$	P _{tot}	83	W
Gate-emitter voltage	V _{GE}	±20	V
Maximum Junction Temperature	TJ	175	°C
DIODE (D12, D14, D20, D21, D22)			
Peak Repetitive Reverse Voltage	V_{RRM}	650	V
Forward Current, DC @ T _h = 80°C (per Diode)	IF	50	Α
Nonrepetitive Peak Surge Current (Surge applied at rated load conditions halfwave, single phase, 60 Hz)	I _{FSM}	225	Α
Power Dissipation Per Diode $T_j = T_{jmax}, T_h = 80^{\circ}C$	P _{tot}	86	W
Maximum Junction Temperature	T _J	175	°C
THERMAL PROPERTIES			
Operating Temperature under switching condition	T _{VJ OP}	-40 to (T _{jmax} - 25)	°C
Storage Temperature range	T _{stg}	-40 to 125	°C
NSULATION PROPERTIES	•		
Isolation test voltage, t = 2 min, 60 Hz	V _{is}	4000	Vac
Creepage distance		12.7	mm

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

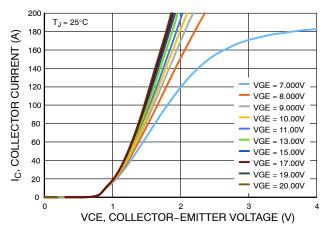
Parameter	Test Condition	Symbol	Min	Тур	Max	Unit
GBT (T11, T12, T13, T14, T21, T22)	•					
Collector-emitter cutoff current	V _{GE} = 0 V, V _{CE} = 650 V	I _{CES}	_	_	300	μΑ
Collector-emitter saturation voltage	V _{GE} = 15 V, I _C = 75 A, T _j = 25°C V _{GE} = 15 V, I _C = 75 A, T _j = 150°C	V _{CE(sat)}	- -	1.56 1.76	2.22 –	V
Gate-emitter threshold voltage	$V_{GE} = V_{CE}$, $I_C = 75$ mA	V _{GE(TH)}	3.1	4.45	5.2	V
Gate leakage current	V _{GE} = 20 V, V _{CE} = 0 V	I _{GES}	-	-	400	nA
Turn-on delay time	T _j = 25°C	t _{d(on)}	-	38	_	ns
Rise time	V_{CE} =350 V, I _C = 80 A V _{GE} = 15 V, -9 V, R _G = 10 Ω	t _r	-	34	-	
Turn-off delay time		t _{d(off)}	-	129	-	
Fall time	7	t _f	-	17	-	
Turn on switching loss		E _{on}	-	0.606	=	mJ
Turn off switching loss	7	E _{off}	-	0.903	-	
Turn-on delay time	T _j = 125°C	t _{d(on)}	-	37	-	ns
Rise time	$V_{CE} = 350 \text{ V}, I_{C} = 80 \text{ A}$ $V_{GE} = 15 \text{ V}, -9 \text{ V}, R_{G} = 10 \Omega$	t _r	-	34	-	
Turn-off delay time		t _{d(off)}	-	139	-	
Fall time	7	t _f	-	23	-	
Turn on switching loss	7	E _{on}	-	1.024	-	mJ
Turn off switching loss	\neg	E _{off}	_	1.141	_	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified) (continued)

Parameter	Test Condition	Symbol	Min	Тур	Max	Unit
IGBT (T11, T12, T13, T14, T21, T22)						
Input capacitance	V _{CE} = 30 V, V _{GE} = 0 V, f = 1 MHz	C _{ies}	-	5665	-	pF
Output capacitance	1	C _{oes}	-	205	_	1
Reverse transfer capacitance	1	C _{res}	-	100	_	
Gate charge total	$V_{CE} = 480 \text{ V}, I_{C} = 50 \text{ A}, V_{GE} = \pm 15 \text{ V}$	Qg	-	550	_	nC
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2.1 Mil ±2%	R_{thJH}	-	1.15	_	°C/W
Thermal Resistance - chip-to-case	$\lambda = 2.9 \text{ W/mK}$	R _{thJC}	-	0.75	_	°C/W
IGBT INVERSE DIODE (D12, D14, D21, D2	22)					
Forward voltage	I _F = 50 A, T _j = 25°C I _F = 50 A, T _j = 175°C	V _F	_ _	2.25 1.7	2.7 -	V
Reverse Recovery Time		t _{rr}	_	63	-	ns
Reverse Recovery Current	T _i = 25°C	Q _{rr}	-	552	_	nc
Peak Reverse Recovery Current	$V_{CE} = 350 \text{ V}, I_{C} = 80 \text{ A}$	I _{rrm}	-	25	_	Α
Peak Rate of Fall of Recovery Current	$V_{GE} = 15 \text{ V}, -9 \text{ V}, R_{G} = 10 \Omega$	Di/dt _{max}	-	1.80	_	A/μs
Reverse Recovery Energy	1	E _{rr}	-	136	_	μJ
Reverse Recovery Time		t _{rr}	-	135	=	ns
Reverse Recovery Current	T _i = 125°C	Q _{rr}	-	1538	=	nc
Peak Reverse Recovery Current	$V_{CF} = 350 \text{ V, I}_{C} = 50 \text{ A}$	I _{rrm}	-	43	_	Α
Peak Rate of Fall of Recovery Current	$V_{GE} = 15 \text{ V}, -9 \text{ V}, R_{G} = 10 \Omega$	Di/dt _{max}	-	1.60	=	A/μs
Reverse Recovery Energy]	E _{rr}	-	346	=	μJ
Thermal Resistance - chip-to-heatsink	Thermal grease, Thickness = 2.1 Mil ±2%	R_{thJH}	-	1.10	=	°C/W
Thermal Resistance - chip-to-case	$\lambda = 2.9 \text{ W/mK}$	R _{thJC}	-	0.79	=	°C/W
DIODE (D20)						
Forward voltage	I _F = 50 A, T _j = 25°C I _F = 50 A, T _j = 175°C	V _F	_ _	2.25 1.7	2.7 -	V
Reverse leakage current	V _{CE} = 650 V, V _{GE} = 0 V	I _r	-	-	300	μΑ
Thermal Resistance – chip-to-heatsink	Thermal grease, Thickness = 2.1 Mil ±2%	R_{thJH}	-	1.10	_	°C/W
Thermal Resistance - chip-to-case	λ = 2.9 W/mK	R_{thJC}	-	0.79	_	°C/W
THERMISTOR CHARACTERISTICS						
Nominal resistance	T = 25°C	R ₂₅	-	22	-	kΩ
Nominal resistance	T = 100°C	R ₁₀₀	-	1486	-	Ω
Deviation of R25		R/R	-5	-	5	%
Power dissipation		P _D	-	200	-	mW
Power dissipation constant			-	2	-	mW/°C
B-value	B (25/50), tol ±3%		-	-	3950	°C
B-value	B (25/100), tol ±3%		-	-	3998	°C
NTC reference			-	_	В	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

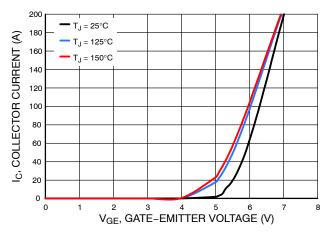
TYPICAL CHARACTERISTICS - IGBT (T11, T12, T13, T14, T21, T22)



200 T_J = 150°C € COLLECTOR CURRENT 160 140 120 VGE = 7.000V VGE = 8.000V 100 VGE = 9.000V VGE = 10.00V VGE = 11.00V VGE = 13.00V 60 VGE = 15.00V 40 • VGE = 17.00V <u>ن</u> VGE = 19.00V 20 VGE = 20.00V VCE, COLLECTOR-EMITTER VOLTAGE (V)

Figure 3. Typical Output Characteristics

Figure 4. Typical Output Characteristics



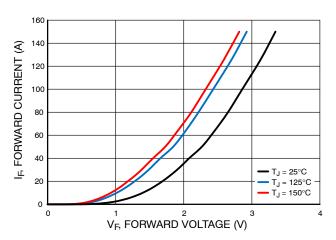
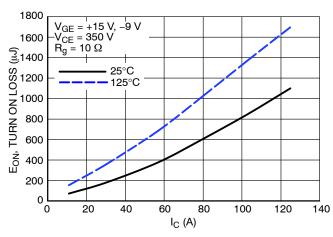


Figure 5. Typical Transfer Characteristics

Figure 6. Diode Forward Characteristics

TYPICAL CHARACTERISTICS - (T11, T12, T13, T14) IGBT COMMUTATES D21, D22 DIODE



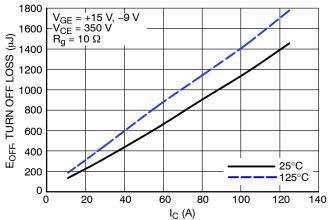


Figure 7. Typical Turn ON Loss vs. IC

Figure 8. Typical Turn OFF Loss vs. IC

TYPICAL CHARACTERISTICS - (T11, T12, T13, T14) IGBT COMMUTATES D21, D22 DIODE (CONTINUED)

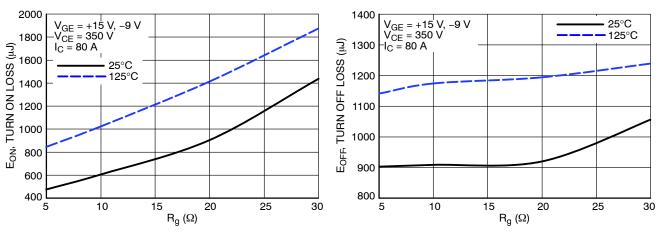


Figure 9. Typical Turn ON Loss vs. RG

Figure 10. Typical Turn OFF Loss vs. RG

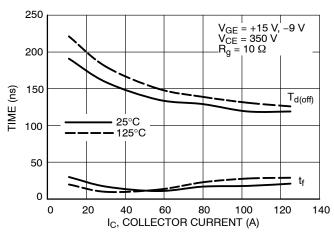


Figure 11. Typical Turn-Off Switching Time vs. IC

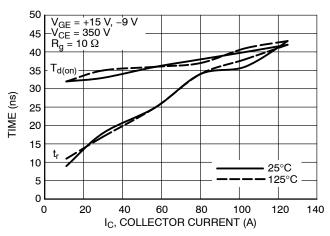


Figure 12. Typical Turn-On Switching Time vs. IC

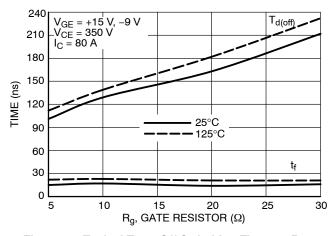


Figure 13. Typical Turn-Off Switching Time vs. Rg

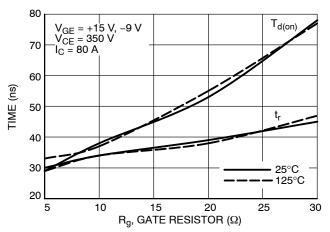


Figure 14. Typical Turn-On Switching Time vs. Rg

TYPICAL CHARACTERISTICS - (T21, T22) IGBT COMMUTATES D20 DIODE

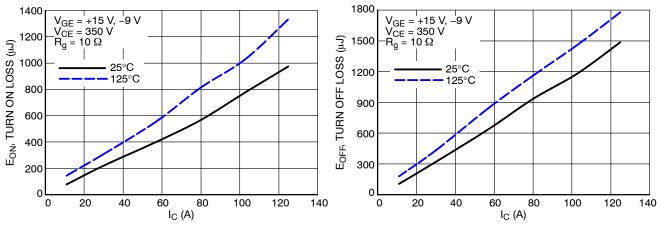


Figure 15. Typical Turn ON Loss vs. IC

Figure 16. Typical Turn OFF Loss vs. IC

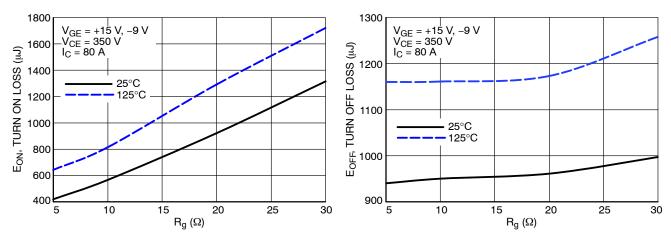


Figure 17. Typical Turn ON Loss vs. RG

Figure 18. Typical Turn OFF Loss vs. RG

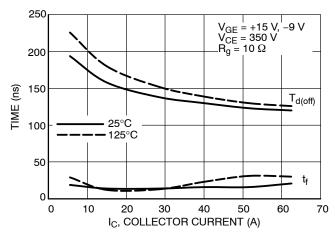


Figure 19. Typical Turn-Off Switching Time vs. IC

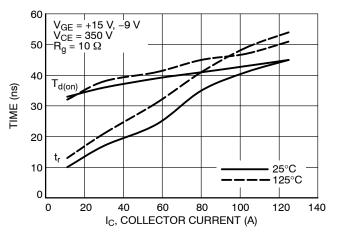
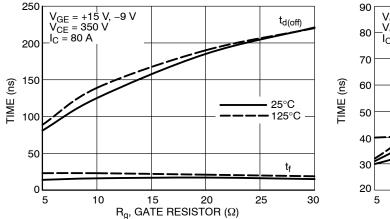


Figure 20. Typical Turn-On Switching Time vs. IC

TYPICAL CHARACTERISTICS - (T21, T22) IGBT COMMUTATES D20 DIODE (CONTINUED)



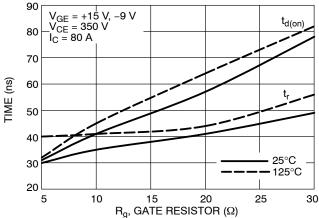
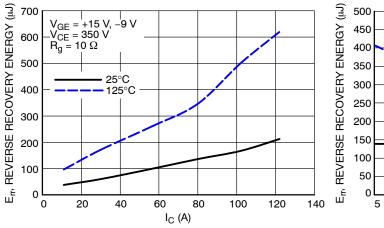


Figure 21. Typical Turn-Off Switching Time vs. Rg

Figure 22. Typical Turn-On Switching Time vs. Rg

TYPICAL CHARACTERISTICS - DIODE



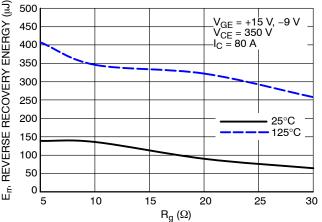
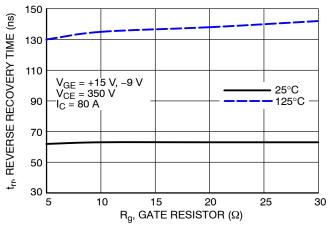


Figure 23. Typical Reverse Recovery Energy Loss vs. IC

Figure 24. Typical Reverse Recovery Energy Loss vs. RG



REVERSE RECOVERY CHARGE (nC) 1800 1600 1400 1200 V_{GE} = +15 V, -9 V -V_{CE} = 350 V 25°C 1000 125°C I_C = 80 A 800 600 400 200 10 20 15 25 30 R_g , GATE RESISTOR (Ω)

Figure 25. Typical Reverse Recovery Time vs. Rg

Figure 26. Typical Reverse Recovery Charge vs. Rg

TYPICAL CHARACTERISTICS - DIODE (CONTINUED)

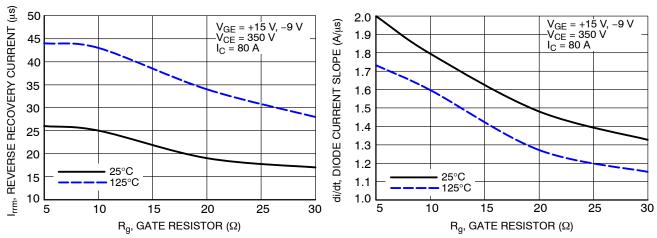


Figure 27. Typical Reverse Recovery Peak Current vs. Rg

Figure 28. Typical di/dt vs. Rg

TYPICAL CHARACTERISTICS

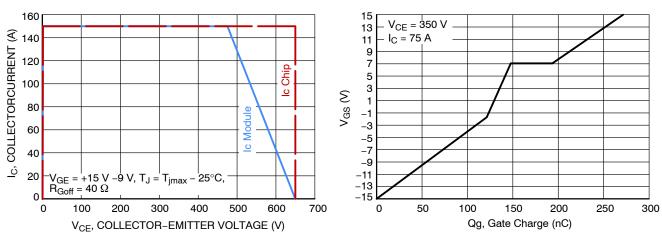


Figure 29. RBSOA Reverse Safe Operating Area

Figure 30. IGBT Gate Charge

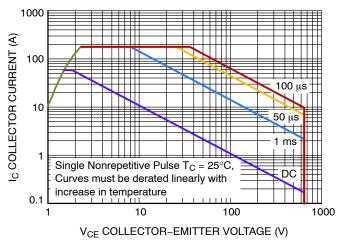


Figure 31. IGBT Safe Operating Area

TYPICAL THERMAL CHARACTERISTICS

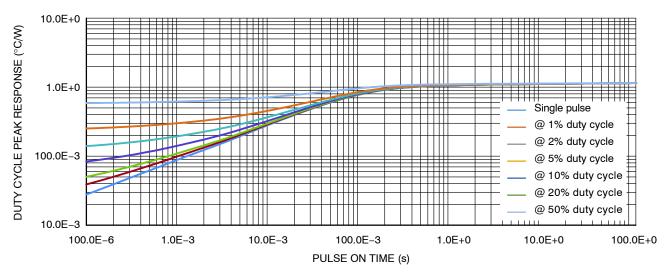


Figure 32. Transient Thermal Impedance - IGBT

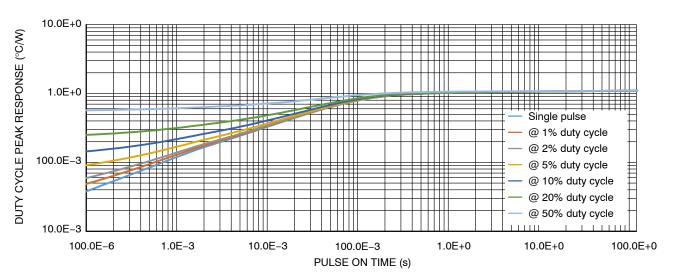
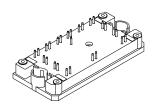


Figure 33. Transient Thermal Impedance - Diode

ORDERING INFORMATION

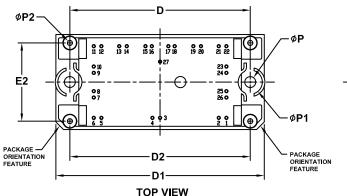
Device	Package Type	Shipping
NXH75M65L4Q1SG (Solder Pin)	PIM27, 71x37.4 Q1PACK	21 Units / BTRAY
NXH75M65L4Q1PTG (Pressfit Pin)	PIM27, 71x37.4 Q1PACK	21 Units / BTRAY

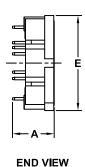




PIM27, 71x37.4 (SOLDER PIN) CASE 180CA ISSUE B

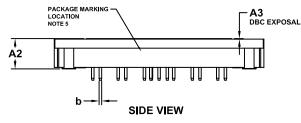
DATE 14 DEC 2022





NOTE 4

	MILLIMETERS			
DIM	MIN.	NOM.	MAX.	
Α	15.90	16.40	16.90	
A2	11.70	11.90	12.10	
A3	0.00	0.20	0.60	
b	0.95	1.00	1.05	
b1	0.75	0.80	0.85	
D	70.80	71.00	71.20	
D1	81.70	82.00	82.30	
D2	70.80	71.00	71.20	
E	37.10	37.40	37.70	
E2	30.60	30.80	31.00	
Р	4.10	4.30	4.50	
P1	9.30	9.50	9.70	
P2	1.80	2.00	2.20	



NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS 6 AND 61 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A1
- 4. PIN POSITION TOLERANCE IS ± 0.4mm
- 5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES

	PIN POSI	TION		PIN POSI	TION
PIN	Х	Υ	PIN	Х	Υ
1	52.20	0.00	15	20.35	28.20
2	49.20	0.00	16	22.85	28.20
3	26.10	0.00	17	29.35	28.20
4	23.10	0.00	18	31.85	28.20
5	3.00	0.00	19	39.20	28.20
6	0.00	0.00	20	42.20	28.20
7	0.00	8.00	21	49.20	28.20
8	0.00	10.50	22	52.20	28.20
9	0.00	17.70	23	52.20	20.20
10	0.00	20.20	24	52.20	17.70
11	0.00	28.20	25	52.20	10.50
12	3.00	28.20	26	52.20	8.00
13	10.00	28.20	27	26.10	22.10
14	13.00	28.20			

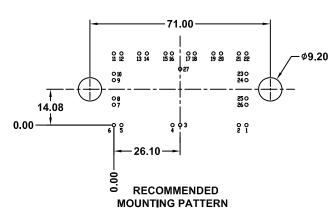
DOCUMENT NUMBER: 98AON20006H Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION: PIM27, 71x37.4 (SOLDER PIN) PAGE 1 O	F 2

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PIM27, 71x37.4 (SOLDER PIN)

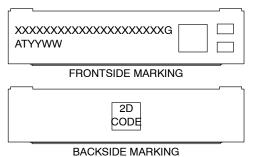
CASE 180CA ISSUE B

DATE 14 DEC 2022



* For additional Information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code

G = Pb-Free Device

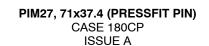
AT = Assembly & Test Site Code YYWW = Year and Work Week Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " • ", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	PIM27, 71x37.4 (SOLDER PIN)		PAGE 2 OF 2	

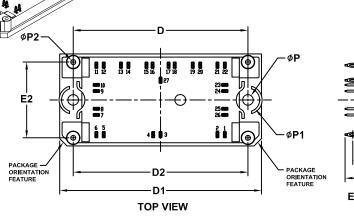
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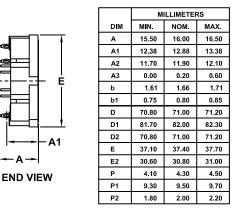


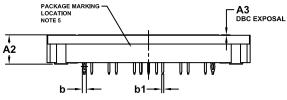


NOTE 4

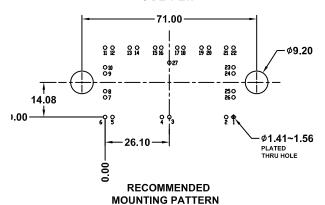
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SIDE VIEW



* For additional Information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS b AND b1 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A1
- 4. PIN POSITION TOLERANCE IS ± 0.4mm
- 5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES

P I N	Х	Υ	PIN	Х	Υ
1	52.20	0.00	15	20.35	28.20
2	49.20	0.00	16	22.85	28.20
3	26.10	0.00	17	29.35	28.20
4	23.10	0.00	18	31.85	28.20
5	3.00	0.00	19	39.20	28.20
6	0.00	0.00	20	42.20	28.20
7	0.00	8.00	21	49.20	28.20
8	0.00	10.50	22	52.20	28.20
9	0.00	17.70	23	52.20	20.20
10	0.00	20.20	24	52.20	17.70
11	0.00	28.20	25	52.20	10.50
12	3.00	28.20	26	52.20	8.00
13	10.00	28.20	27	26.10	22.10

П

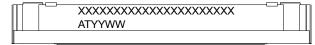
PIN POSITION

PIN POSITION

13.00

28.20

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code

AT = Assembly & Test Site Code

YYWW = Year and Work Week Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	PIM27, 71X37.4 (PRESSFIT PIN)		PAGE 1 OF 1	

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